

Notice of References Cited	Application/Control No. 10/773,610		Applicant(s)/Patent Under Reexamination YAMANAKA ET AL.	
	Examiner Emmanuel Bayard		Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0101068	05-2004	Wang et al.	375/324
*	B	US-2004/0032905	02-2004	Dittrich et al.	375/233
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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